

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10585691	FUKUSHIMA ET AL.
	Examiner HEE-YONG KIM	Art Unit 2621

SEARCHED

Class	Subclass	Date	Examiner
348	42-60	4/20/2010	H.K
348	42-60	9/27/2010	H.K

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search at Edan	4/18/2010	H.K
parallax and lenticul\$3 and longitudinal	4/20/2010	H.K
parallax and lenticul\$3 and 45 degree	4/20	H.K
348/42-60.ccls. and (view\$2 (specific or position or eye))	4/20	H.K
48/42-60.ccls. and (view\$2 (specific or position or eye)) and lentic\$4 and (shift same parallax)	4/20	H.K
parallax and toshiba.as.	4/20	H.K
parallax and lentic\$4 and (adjust\$3 with view\$3)	4/22	H.K
parallax and lentic\$4 and (shift with view\$3)	4/22	H.K
(pin-hole or pinhole) camear and (focal length and distance)	4/23	H.K
Discussed with Dave C at QEM and suggest string (lenticular and (shift same parallax)	4/20	H.K and D.C
Discussed with Andy Rao and he suggesed class 348/42-60, searched to get one reference (6,329,963) but it is not relevant.	4/20, 4/21	H.K and A.R
horizontal parallax and (shift\$3 with vertical\$2)	9/20	H.K
(parallax or multiple-view or multi view) and (shift\$3 with vertical)	9/20	H.K
Discussed with Andy about Allowance	9/22	H.K and A.R
Discussed with Marsha Banks about Allowance (Direct to Check Double patenting and 101 Issue)	9/23	H.K and M.B
Discussed with Marsha Banks about Allowance (Non-Final Rejection because 101 rejection of claim 19, other claims are allowable)	9/27	H.K and M.B

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
348	42-60	9/27/2010	H.K